

Notice of References Cited	Application/Control No. 10/540,670		Applicant(s)/Patent Under Reexamination CHANG, CHIN	
	Examiner Robert R. Rainey		Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,717,355	04-2004	Takahashi et al.	313/503
*	B	US-6,628,249	09-2003	Kamikawa et al.	345/44
*	C	US-2005/0001225	01-2005	Yoshimura et al.	257/098
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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